

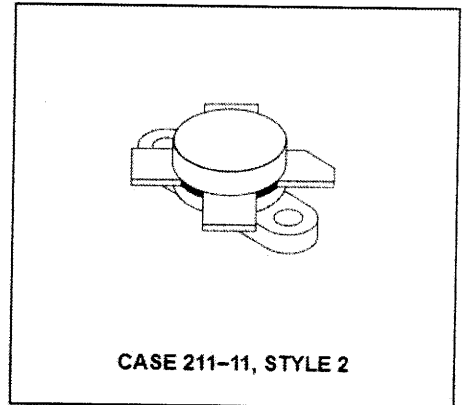
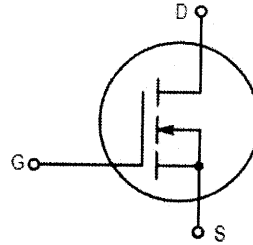
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MRF151

150 W, 50 V, 175 MHz
 N-CHANNEL
 BROADBAND
 RF POWER MOSFET



The RF MOSFET Line
RF Power Field-Effect Transistor
 N-Channel Enhancement-Mode MOSFET

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	125	Vdc
Drain-Gate Voltage	V_{DGO}	125	Vdc
Gate-Source Voltage	V_{GS}	± 40	Vdc
Drain Current — Continuous	I_D	16	Adc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	300 1.71	Watts W/°C
Storage Temperature Range	T_{stg}	-65 to +150	°C
Operating Junction Temperature	T_J	200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.6	°C/W

NOTE — **CAUTION** — MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.



Quality Semi-Conductors

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-Source Breakdown Voltage ($V_{GS} = 0$, $I_D = 100$ mA)	$V_{(BR)DSS}$	125	—	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = 50$ V, $V_{GS} = 0$)	I_{DSS}	—	—	5.0	mAdc
Gate-Body Leakage Current ($V_{GS} = 20$ V, $V_{DS} = 0$)	I_{GSS}	—	—	1.0	μ Adc

ON CHARACTERISTICS

Gate Threshold Voltage ($V_{DS} = 10$ V, $I_D = 100$ mA)	$V_{GS(th)}$	1.0	3.0	5.0	Vdc
Drain-Source On-Voltage ($V_{GS} = 10$ V, $I_D = 10$ A)	$V_{DS(on)}$	1.0	3.0	5.0	Vdc
Forward Transconductance ($V_{DS} = 10$ V, $I_D = 5.0$ A)	g_{fs}	5.0	7.0	—	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance ($V_{DS} = 50$ V, $V_{GS} = 0$, $f = 1.0$ MHz)	C_{iss}	—	350	—	pF
Output Capacitance ($V_{DS} = 50$ V, $V_{GS} = 0$, $f = 1.0$ MHz)	C_{oss}	—	220	—	pF
Reverse Transfer Capacitance ($V_{DS} = 50$ V, $V_{GS} = 0$, $f = 1.0$ MHz)	C_{rss}	—	15	—	pF

FUNCTIONAL TESTS

Common Source Amplifier Power Gain, $f = 30$; 30.001 MHz ($V_{DD} = 50$ V, $P_{out} = 150$ W (PEP), $I_{DQ} = 250$ mA) $f = 175$ MHz	G_{ps}	18 —	22 13	— —	dB
Drain Efficiency ($V_{DD} = 50$ V, $P_{out} = 150$ W (PEP), $f = 30$; 30.001 MHz, I_D (Max) = 3.75 A)	η	40	45	—	%
Intermodulation Distortion (1) ($V_{DD} = 50$ V, $P_{out} = 150$ W (PEP), $f = 30$ MHz, $f_2 = 30.001$ MHz, $I_{DQ} = 250$ mA)	$IMD_{(d3)}$ $IMD_{(d11)}$	— —	-32 -60	-30 —	dB
Load Mismatch ($V_{DD} = 50$ V, $P_{out} = 150$ W (PEP), $f_1 = 30$; 30.001 MHz, $I_{DQ} = 250$ mA, VSWR 30:1 at all Phase Angles)	ψ	No Degradation in Output Power			

CLASS A PERFORMANCE

Intermodulation Distortion (1) and Power Gain ($V_{DD} = 50$ V, $P_{out} = 50$ W (PEP), $f_1 = 30$ MHz, $f_2 = 30.001$ MHz, $I_{DQ} = 3.0$ A)	G_{ps} $IMD_{(d3)}$ $IMD_{(d9-13)}$	— — —	23 -50 -75	— — —	dB
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